

FORM PTO-1449 (REV.7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 854063.679D1	APPLICATION NO.
INFORMATION DISCLOSURE STATEMENT <i>(Use several sheets if necessary)</i>		APPLICANTS Raffaele Zambrano et al.	
		FILING DATE March 18, 2004	GROUP ART UNIT

U.S. PATENT DOCUMENTS


*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
lm	AA	5,475,248	12/12/95	Takenaka	257	295	
	AB	5,481,490	01/02/96	Watanabe et al.	365	145	
	AC	5,578,867	11/26/96	Argos, Jr. et al.	257	632	
	AD	5,716,875	02/10/98	Jones, Jr. et al.	438	3	
	AE	5,638,319	06/10/97	Onishi et al.	365	145	
	AF	5,750,419	05/12/98	Zafar	438	3	
	AG	5,811,847	09/22/98	Joshi et al.	257	296	
	AH	5,864,153	01/26/99	Nagel et al.	257	296	
	AI	5,956,594	09/21/99	Yang et al.	438	396	
✓	AJ	5,965,942	10/12/99	Itoh et al.	257	761	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
lm	AK	0 793 274 A1	09/03/97	EP ✓		
	AL ²	WO 98/05071	02/05/98	PCT ✓		
	AM ³	196 40 246 A1	04/02/98	DE		
	AN ⁴	0 837 504 A2	04/22/98	EP		
✓	AO ⁵	0 996 160 A1	04/26/00	EP		

OTHER PRIOR ART *(Including Author, Title, Date, Pertinent Pages, Etc.)*

lm	AP	Yamazaki, T. et al., "Advanced 0.5µm FRAM Device Technology with Full Compatibility of Half-Micron CMOS Logic device," IEEE, pp. 25.5.1-25.5.4, XP000855871, December 1997.
	AQ	
	AR	

EXAMINER 	DATE CONSIDERED 12-27-4
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* EXAMINER: Initial if reference considered, whether or not criteria is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant(s).

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<i>Im</i>	5,973,342	10/26/99	Nakamura	257	295		
<i>1</i>	5,981,382	11/09/99	Konecni et al.	438	646		
	5,990,507	11/23/99	Mochizuki et al.	257	295		
	5,994,153	11/30/99	Nagel et al.	438	3		
	5,998,296	12/07/99	Saran et al.	438	685		
	6,037,252	03/14/00	Hillman et al.	438	637		
	6,043,529	03/28/00	Hartner et al. /	257	306		
	6,051,858	04/18/00	Uchida et al.	257	295		
	6,075,264	06/13/00	Koo	257	295		
	6,091,599	07/18/00	Amamiya	361	306.3		
	6,121,083	09/19/00	Matsuki	438	254		
	6,180,974	01/30/01	Okutoh et al.	257	306		
	6,194,311	02/27/01	Nakajima	438	660		
	6,197,631	03/06/01	Ishihara	438	240		
	6,239,460	05/29/01	Kuroiwa et al.	257	300		
	6,281,537	08/28/01	Kim	257	295		
<i>✓</i>	6,313,539	11/06/01	Yokoyama et al.	257	761		
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY			TRANSLATION YES NO	
			/				
			/				
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			/				
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